

QUASES-Tougaard XPS-Workshop - Sven Tougaard / 1 day



This workshop, presented by **Sven Tougaard** (Prof at SDU, Denmark), is for students and researchers who want to make more accurate and more detailed analysis of nano-structured surfaces by XPS, using the facilities in the QUASES-Tougaard software package.

The workshop consists of five sessions

1. **A lecture on quantitative XPS surface analysis.** Discussion of deficiencies in traditional quantitative XPS analysis and of how the accuracy can be enhanced by analysis of both peak intensity and the background of inelastically scattered electrons.
2. **An interactive lecture session** where the different aspects, facilities and capabilities of the QUASES-Tougaard software package are presented and discussed. You will do simple hands on operations with the software in this session.
3. **Hands on: You will do a guided step by step analysis of a couple of cases.** The purpose is to become familiar with the steps needed to get from the raw XPS-spectra to the complete quantitative analysis of the nano-structure.
4. **Hands on: You will be given sets of raw XPS spectra taken from various samples.** From these, you will use the software to determine the quantitative nano-structure for a handful of practical examples. You will be given individual guidance so you can advance at your own pace and users with some experience can move ahead more quickly.
5. **You are encouraged to bring your own spectra.** In this last part of the workshop you will get personal guidance on the potential applications of QUASES to your research. Get also guidance on what spectra you should record to get most benefit for your specific research.

Duration

~ 6 hours, depending on the number of participants who bring spectra for session 5.

Preparation & requirements

As a preparation for your participation, please go to the web site, download and spend a couple of hours looking at the users manual and the several tutorial examples.

No computer will be available, **please bring your own laptop**. Participants **with a valid software license** are requested to bring a laptop with the software installed.

For those **without a license**, the software will be provided for your use during the workshop.

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QUASES

Software packages to characterize surface nano-structures by analysis of electron spectra

QUASES-Tougaard (developed by Sven Tougaard)

[Example - practical application](#)

[Principle of XPS peak shape analysis](#)

[Recent papers that used the software](#)

[Download the QUASES-Tougaard manual](#)

[Tutorial example](#)

[Lecture on QUASES-Tougaard](#)

[Difference between the ARXPS and peak shape methods](#)

[References](#)

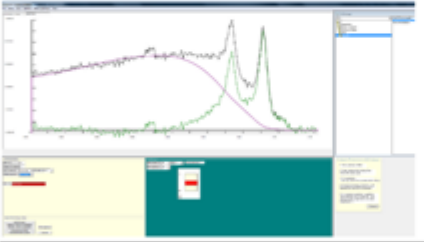
[How to order](#)

The QUASES-Tougaard software is for accurate determination of the structure and composition of nano-structures on surfaces. The information is obtained from analysis of both the peak intensity and the background of inelastically scattered electrons.

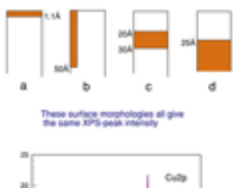
The software builds on the fact that the XPS peak shape depends on the surface structure of the solid on the nano-meter depth scale. By proper analysis of the peak intensity and shape, the quantitative composition of the surface can therefore be determined.

The software package provides all the necessary tools needed to do the analysis.

The method is non-destructive and therefore allows also to study the change in morphology of a surface nano-structure during surface treatment as e.g. chemical reaction, annealing, growth etc.



The problem with traditional XPS analysis.



These surface morphologies all give the same XPS peak intensity.

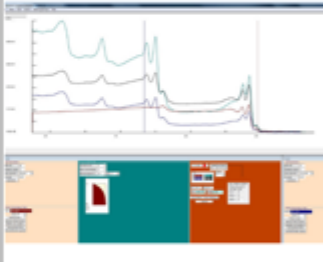
Traditional XPS analysis is based on peak intensities. The peak intensity is however not a good measure for the concentration of atoms in the surface region.

The situation is illustrated in the figure. The four quite

Menu Driven Graphical User Interface

The software has a menu driven graphical user interface allows the user to interactively perform the analysis spectrum by changing the surface structure. A graphical representation of the assumed in-depth composition as the resulting spectrum calculated for this profile simultaneously on the screen together with the measured spectrum.

It includes programs that determine the background spectrum corresponding to the spectrum from a simulation as programs to calculate a model spectrum corresponding to a specified in-depth concentration profile.



The QUASES Software Package comes complete with documentation, including a comprehensive user manual. It also includes several tutorial examples with which the user can directly work through step by step detailed instructions.

The software runs under Windows. It is optimized for speed and the typical time to calculate a spectrum is only a fraction of a second.

The software package includes facilities for

- Quantitative and non-destructive in-depth analysis of nano-structures

Brief description of the software

Traditional quantitative XPS analysis relies on the assumption that the sample is homogeneous in the outermost 1-2 nm. This is usually not the case and can result in huge inaccuracies.

The QUASES software is for accurate XPS determination of the structure and composition of nano-structures on surfaces. The information is obtained from analysis of both the peak intensity and the background of inelastically scattered electrons. Due to inelastic electron scattering, the XPS peak shape varies significantly with depth composition on the nano-meter scale. By proper analysis of the peak intensity and shape, quantitative composition can therefore be determined. The software package provides all the necessary tools needed to do the analysis.

The method is non-destructive and therefore it also allows to study the gradual change in morphology of a surface nano-structure during surface treatment as e.g. chemical reaction, annealing, growth etc.



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Find more information on the software at this web page where you can download the users manual, several tutorial examples, scientific papers etc.